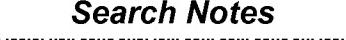


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/680,006	KAPLAN, FREDERICK	
	Examiner	Art Unit	
	ALEX LIEW	2624	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Interference search		9/1/2008	AL